

Search Notes

Application/Control No.

10/612,243

Examiner

John L. Goodrow

Applicant(s)/Patent under
Reexamination

QIAN ET AL.

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner
430	109.31	8/16/2005	JG
	109.1		
	109.3		
	120		
	137.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
430	109.31	8/16/2005	
	109.1;3		
430	120		
430/137.1			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor name search	8/16/2005	JG